Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/562,817	OOTAKE ET AL.
Examiner	Art Unit
Marc S. Zimmer	1712

SEARCHED		
Subclass	Date	Examiner
		-
	Subclass	Subclass Date

INT	ERFERENCE SEARCHED		INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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